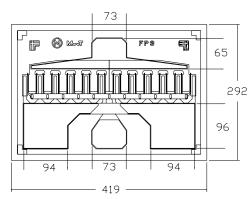


# MwT-PH9

28 GHz Medium Power AlGaAs/InGaAs PHEMT Preliminary Data Sheet May 2011

### Features:

- +27.0 dBm Output Power at 12 GHz
- 10.0 dB Small Signal Gain at 12 GHz
- 50 % PAE at 12 GHz
- 0.3 x 750 Micron Refractory Metal/Gold Gate
- Excellent for High Power, Gain, and High Power Added Efficiency Applications
- Ideal for Commercial, Military, Hi-Rel Space Applications



Chip Dimensions: 419 x 292 microns Chip Thickness: 100 microns

# **Description:**

The MwT-PH9 is a AlGaAs/InGaAs PHEMT (Pseudomorphic-High-Electron-Mobility-Transistor) device whose nominal 0.3 micron gate length and 750 micron gate width make it ideally suited for applications requiring high-gain and power up to 28 GHz frequency range with power outputs ranging from 400 to 500 milli-watts. The device is equally effective for either wideband (e.g. 6 to 18 GHz) or narrow-band applications. The chip is produced using MwT's reliable metal systems and all devices from each wafer are screened to insure reliability. All chips are passivated using MwT's patented "Diamond-Like Carbon" process for increased durability.

<b>Electrical</b>	Specifications:	•	at Ta= 25 ℃

	ai opcomoations.				
SYMBOL	PARAMETERS & CONDITIONS	FREQ	UNITS	MIN	TYP
P1dB	Output Power at 1dB Compression Vds=7.0 V Ids=0.6xIDSS=150 mA	12 GHz	dBm	26.0	27.0
SSG	Small Signal Gain VDS=7.0 V Ids=0.6xIDSS=150 mA	12 GHz	dB	9.0	10.0
PAE	Power Added Efficiency at P1dB VDS=7.0 V Ids=0.6xIDSS=150 mA	12 GHz	%		50
IDSS	Recommended IDSS Range for Optimum P1dB		mA		120- 292

## DC Specifications: • at Ta= 25 ℃

DO Opcon	iloationo.				
SYMBOL	PARAMETERS & CONDITIONS	UNITS	MIN	TYP	MAX
IDSS	Saturated Drain Current Vds=4.0 V Vgs=0.0 V	mA	144		318
Gm	Transconductance Vds=2.5 V Vgs=0.0 V	mS	150	200	
Vp	Pinch-off Voltage Vds=3.0 V Ids=5.0 mA	V		-1.2	-2.5
BVGSO	Gate-to-Source Breakdown Voltage  Igs= -1.0 mA	V	-6.0	-12.0	



28 GHz Medium Power AlGaAs/InGaAs PHEMT Preliminary Data Sheet May 2011

BVGDO Gate-to-Drain Breakdown Voltage Igd= -1.0 mA

Chip Thermal Resistance

V

-10.0

-13.0

°C/W

56\*

### MAXIMUM RATINGS AT Ta = 25 °C

Symbol	Parameter	Units	Cont Max1	Absolute Max2
VDS	Drain to Source Volt.	V	7.5	8.0
Tch	Channel Temperature	<b>°</b> C	+150	+175
Tst	Storage Temperature	°C	-65 to+160	+180
Pin	RF Input Power	mW	240	360
Pt	Total Power Dissipation	mW	2700	3300

#### Notes:

Rth

- 1. Exceeding any one of these limits in continuous operation may reduce the mean-time- to-failure below the design goal.
- 2. Exceeding any one of these limits may cause permanent damage.

#### **ORDERING INFORMATION:**

When placing order or inquiring, please specify BIN range, wafer number, if known, and visual screening level required. For details of BIN Selection and Safe Handling Procedure please see supplementary information in available PDF on our website <a href="https://www.mwtinc.com">www.mwtinc.com</a>.

<sup>\*</sup> Overall Rth depends on case mounting